

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination VAJAPEYAM ET AL.	
		Examiner David J. Huisman	Art Unit 2183	Page 1 of 1

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	C	US-6,018,798	01-2000	Witt et al.	712/220
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	M	US-			

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NON-PATENT DOCUMENTS

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	U	Sullery, "Beyond ILP II: SMT and Variants," May 2000, pp.1-6
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.